# Package 'AIUQ'

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Type Package

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<b>Description</b> Uncertainty quantification and inverse estimation by probabilistic generative models from the beginning of the data analysis. An example is a Fourier basis method for inverse estimation in scattering analysis of microscopy videos. It does not require specifying a certain range of Fourier bases and it substantially reduces computational cost via the generalized Schur algorithm. See the reference: Mengyang Gu, Yue He, Xubo Liu and Yimin Luo (2023), <doi:10.48550 arxiv.2309.02468=""></doi:10.48550>
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aniso\_SAM

Scattering analysis of microscopy for anisotropic processes

# Description

Fast parameter estimation in scattering analysis of microscopy for anisotropic processes, using AIUQ method.

# Usage

Index

```
aniso_SAM(
  intensity = NA,
  intensity_str = "T_SS_mat",
  pxsz = 1,
  sz = c(NA, NA),
 mindt = 1,
 AIUQ\_thr = c(1, 1),
 model_name = "BM",
  sigma_0_2_ini = NaN,
  param_initial = NA,
  num\_optim = 1,
  msd_fn = NA,
 msd\_grad\_fn = NA,
  num_param = NA,
  uncertainty = FALSE,
 M = 50,
  sim_object = NA,
  msd_truth = NA,
 method = "AIUQ",
  index_q_AIUQ = NA,
 message_out = TRUE,
```

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```
square = FALSE
)
```

### **Arguments**

intensity intensity profile. See 'Details'.

intensity\_str structure of the intensity profile, options from ('SST\_array','S\_ST\_mat','T\_SS\_mat').

See 'Details'.

pxsz size of one pixel in unit of micron, 1 for simulated data

frame size of the intensity profile in x and y directions, number of pixels con-

tained in each frame equals sz\_x by sz\_y.

mindt minimum lag time, 1 for simulated data

AIUQ\_thr threshold for wave number selection, numeric vector of two elements with val-

ues between 0 and 1. See 'Details'.

model\_name fitted model, options from ('BM','OU','FBM','OU+FBM', 'user\_defined'), with

Brownian motion as the default model. See 'Details'.

sigma\_0\_2\_ini initial value for background noise. If NA, use minimum value of absolute square

of intensity profile in reciprocal space.

param\_initial initial values for param estimation.

num\_optim number of optimization.

msd\_fn user defined mean squared displacement(MSD) structure, a function of parame-

ters and lag times. NA if model\_name is not 'user\_defined'.

msd\_grad\_fn gradient for user defined mean squared displacement structure. If NA, then

numerical gradient will be used for parameter estimation in 'user\_defined'

model.

num\_param number of parameters need to be estimated in the intermediate scattering func-

tion, need to be non-NA value for user\_defined' model.

uncertainty a logical evaluating to TRUE or FALSE indicating whether parameter uncer-

tainty should be computed.

M number of particles. See 'Details'.

sim\_object NA or an S4 object of class simulation.

msd\_truth true MSD or reference MSD value.

method methods for parameter estimation, options from ('AIUQ', 'DDM').

index\_q\_AIUQ index range for wave number when using AIUQ method. See 'Details'.

message\_out a logical evaluating to TRUE or FALSE indicating whether or not to output the

message.

square a logical evaluating to TRUE or FALSE indicating whether or not to crop the

original intensity profile into square image.

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#### **Details**

For simulated data using aniso\_simulation in AIUQ package, intensity will be automatically extracted from aniso\_simulation class.

By default intensity\_str is set to 'T\_SS\_mat', a time by space×space matrix, which is the structure of intensity profile obtained from aniso\_simulation class. For intensity\_str='SST\_array', input intensity profile should be a space by space by time array, which is the structure from loading a tif file. For intensity\_str='S\_ST\_mat', input intensity profile should be a space by space×time matrix.

By default AIUQ\_thr is set to c(1,1), uses information from all complete q rings. The first element affects maximum wave number selected, and second element controls minimum proportion of wave number selected. By setting 1 for the second element, if maximum wave number selected is less than the wave number length, then maximum wave number selected is coerced to use all wave number unless user defined another index range through index\_q\_AIUQ.

If model\_name equals 'user\_defined', or NA (will coerced to 'user\_defined'), then msd\_fn and num\_param need to be provided for parameter estimation.

Number of particles M is set to 50 or automatically extracted from simulation class for simulated data using simulation in AIUQ package.

By default, using all wave vectors from complete q ring for both AIUQ, unless user defined index range through index\_q\_AIUQ.

#### Value

Returns an S4 object of class aniso\_SAM.

#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# **Examples**

```
library(AIUQ)
# Example 1: Estimation for simulated data
set.seed(1)
aniso_sim = aniso_simulation(sz=100,len_t=100, model_name="BM",M=100,sigma_bm=c(0.5,0.3))
show(aniso_sim)
plot_traj(object=aniso_sim)
aniso_sam = aniso_SAM(sim_object=aniso_sim, model_name="BM",AIUQ_thr = c(0.999,0))
show(aniso_sam)
plot_MSD(aniso_sam,msd_truth = aniso_sam@msd_truth)
```

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aniso\_SAM-class

Anisotropic SAM class

# Description

S4 class for fast parameter estimation in scattering analysis of microscopy for anisotropic processes, using either AIUQ or DDM method.

#### Slots

pxsz numeric. Size of one pixel in unit of micron with default value 1.

mindt numeric. Minimum lag time with default value 1.

sz vector. Frame size of the intensity profile in x and y directions, number of pixels contained in each frame equals sz\_x by sz\_y.

len\_t integer. Number of time steps.

len\_q integer. Number of wave vector.

q vector. Wave vector in unit of um^-1.

d\_input vector. Sequence of lag times.

B\_est\_ini numeric. Estimation of B. This parameter is determined by the noise in the system. See 'References'.

A\_est\_ini vector. Estimation of A(q). Note this parameter is determined by the properties of the imaged material and imaging optics. See 'References'.

I\_o\_q\_2\_ori vector. Absolute square of Fourier transformed intensity profile, ensemble over time.

q\_ori\_ring\_loc\_unique\_index list. List of location index of non-duplicate values for each q
ring.

model\_name character. Fitted model, options from ('BM','OU','FBM','OU+FBM', 'user\_defined'). param\_est matrix. Estimated parameters contained in MSD.

sigma\_2\_0\_est vector. Estimated variance of background noise.

msd\_est matrix. Estimated MSD.

uncertainty logical. A logical evaluating to TRUE or FALSE indicating whether parameter uncertainty should be computed.

msd\_truth matrix. True MSD or reference MSD value.

sigma\_2\_0\_truth vector. True variance of background noise, non NA for simulated data using simulation.

param\_truth matrix. True parameters used to construct MSD, non NA for simulated data using aniso\_simulation.

index\_q vector. Selected index of wave vector.

I\_q matrix. Fourier transformed intensity profile with structure 'SS\_T\_mat'.

AIC numeric. Akaike information criterion score.

mle numeric. Maximum log likelihood value.

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```
msd_x_lower vector. Lower bound of 95% confidence interval of MSD in x directions. msd_x_upper vector. Upper bound of 95% confidence interval of MSD in x directions. msd_y_lower vector. Lower bound of 95% confidence interval of MSD in y directions. msd_y_upper vector. Upper bound of 95% confidence interval of MSD in y directions. param_uq_range matrix. 95% confidence interval for estimated parameters.
```

### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

aniso\_simulation

Simulate anisotropic 2D particle movement

# **Description**

Simulate anisotropic 2D particle movement from a user selected stochastic process, and output intensity profiles.

# Usage

```
aniso_simulation(
  sz = c(200, 200),
 len_t = 200,
 M = 50,
 model_name = "BM",
 noise = "gaussian",
  10 = 20,
  Imax = 255,
  pos0 = matrix(NaN, nrow = M, ncol = 2),
  rho = c(0.95, 0.9),
 H = c(0.4, 0.3),
  sigma_p = 2,
  sigma_bm = c(1, 0.5),
  sigma_ou = c(2, 1.5),
  sigma_fbm = c(2, 1.5)
)
```

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# **Arguments**

sz	frame size of simulated image with default c(200, 200).
len_t	number of time steps with default 200.
М	number of particles with default 50.
model_name	stochastic process simulated, options from ('BM','OU','FBM','OU+FBM'), with default 'BM'.
noise	background noise, options from ('uniform', 'gaussian'), with default 'gaussian'.
10	background intensity, value between 0 and 255, with default 20.
Imax	maximum intensity at the center of the particle, value between 0 and 255, with default 255.
pos0	initial position for M particles, matrix with dimension M by 2.
rho	correlation between successive step and previous step in O-U process, in $x$ , y-directions. A vector of length 2 with values between 0 and 1, default $c(0.95,0.9)$ .
Н	Hurst parameter of fractional Brownian Motion, in $x$ , $y$ -directions. A vector of length 2, value between 0 and 1, default $c(0.4,0.3)$ .
sigma_p	radius of the spherical particle (3sigma_p), with default 2.
sigma_bm	distance moved per time step of Brownian Motion, in x,y-directions. A vector of length 2 with default $c(1,0.5)$ .
sigma_ou	distance moved per time step of Ornstein–Uhlenbeck process, in $x$ , $y$ -directions. A vector of length 2 with default $c(2,1.5)$ .

distance moved per time step of fractional Brownian Motion, in x, y-directions.

### Value

sigma\_fbm

Returns an S4 object of class anisotropic\_simulation.

A vector of length 2 with default c(2,1.5).

# Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

# References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# **Examples**

```
library(AIUQ)
 # -----
 # Example 1: Simple diffusion for 200 images with
      200 by 200 pixels and 50 particles
 aniso_sim_bm = aniso_simulation()
 show(aniso_sim_bm)
 # Example 2: Simple diffusion for 100 images with
          100 by 100 pixels and slower speed
 aniso_sim_bm = aniso_simulation(sz=100,len_t=100,sigma_bm=c(0.5,0.1))
 show(aniso_sim_bm)
 # -----
 # Example 3: Ornstein-Uhlenbeck process
 aniso_sim_ou = aniso_simulation(model_name="0U")
 show(aniso_sim_ou)
aniso_simulation-class
                     Anisotropic simulation class
```

# **Description**

S4 class for anisotropic 2D particle movement simulation.

#### **Details**

```
intensity should has structure 'T_SS_mat', matrix with dimension len_t by sz \times sz. pos should be the position matrix with dimension M \times len_t. See bm_particle_intensity, ou_particle_intensity, fbm_particle_intensity, fbm_ou_particle_intensity.
```

# **Slots**

```
sz vector. Frame size of the intensity profile, number of pixels contained in each frame equals sz[1] by sz[2].
len_t integer. Number of time steps.
noise character. Background noise, options from ('uniform','gaussian').
model_name character. Simulated stochastic process, options from ('BM','OU','FBM','OU+FBM').
M integer. Number of particles.
pxsz numeric. Size of one pixel in unit of micron, 1 for simulated data.
mindt numeric. Minimum lag time, 1 for simulated data.
```

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```
pos matrix. Position matrix for particle trajectory, see 'Details'. intensity matrix. Filled intensity profile, see 'Details'. num_msd matrix. Numerical mean squared displacement (MSD). param matrix. Parameters used to construct MSD. theor_msd matrix. Theoretical MSD. sigma_2_0 vector. Variance of background noise.
```

#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

get\_dqt

Compute observed dynamic image structure function

# Description

Compute observed dynamic image structure function (Dqt) using object of SAM class.

#### Usage

```
get_dqt(object, index_q = NA)
```

### Arguments

object an S4 object of class SAM

index\_q wavevector range used for computing Dqt

#### Value

A matrix of observed dynamic image structure function with dimension len\_q by len\_t-1.

# Author(s)

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### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# **Examples**

```
## Not run:
library(AIUQ)
sim_bm = simulation(len_t=100,sz=100,sigma_bm=0.5)
show(sim_bm)
sam = SAM(sim_object = sim_bm)
show(sam)
Dqt = get_dqt(object=sam)
## End(Not run)
```

get\_isf

Compute empirical intermediate scattering function

# **Description**

Compute empirical intermediate scattering function (ISF) using object of SAM class.

# Usage

```
get_isf(object, index_q = NA, msd_truth = NA)
```

# **Arguments**

object an S4 object of class SAM

index\_q wavevector range used for computing ISF

msd\_truth true or reference MSD

# Value

A matrix of empirical intermediate scattering function with dimension len\_q by len\_t-1.

# Author(s)

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### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# **Examples**

```
## Not run:
library(AIUQ)
sim_bm = simulation(len_t=100,sz=100,sigma_bm=0.5)
show(sim_bm)
sam = SAM(sim_object = sim_bm)
show(sam)
ISF = get_isf(object=sam)
## End(Not run)
```

modeled\_dqt

Compute modeled dynamic image structure function

# **Description**

Compute modeled dynamic image structure function (Dqt) using object of SAM class.

# Usage

```
modeled_dqt(object, index_q = NA, uncertainty = FALSE)
```

# **Arguments**

object an S4 object of class SAM

index\_q wavevector range used for computing Dqt

uncertainty logic evalution

# Value

A matrix of modeled dynamic image structure function with dimension len\_q by len\_t-1.

# Author(s)

modeled\_isf

### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# Examples

```
library(AIUQ)
sim_bm = simulation(len_t=100,sz=100,sigma_bm=0.5)
show(sim_bm)
sam = SAM(sim_object = sim_bm)
show(sam)
modeled_Dqt = modeled_dqt(object=sam)
```

modeled\_isf

Compute modeled intermediate scattering function

# Description

Compute modeled intermediate scattering function (ISF) using object of SAM class.

### Usage

```
modeled_isf(object, index_q = NA)
```

# **Arguments**

object an S4 object of class SAM

index\_q wavevector range used for computing ISF

# Value

A matrix of modeled intermediate scattering function with dimension len\_q by len\_t-1.

### Author(s)

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### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

# **Examples**

```
library(AIUQ)
sim_bm = simulation(len_t=100,sz=100,sigma_bm=0.5)
show(sim_bm)
sam = SAM(sim_object = sim_bm)
show(sam)
modeled_ISF = modeled_isf(object=sam)
```

plot\_intensity

Plot 2D intensity

# **Description**

Function to plot 2D intensity profile for a certain frame, default is to plot the first frame. Input can be a matrix (2D) or an array (3D).

# Usage

```
plot_intensity(
   intensity,
   intensity_str = "T_SS_mat",
   frame = 1,
   sz = NA,
   title = NA,
   color = FALSE
)
```

# Arguments

intensity	intensity profile
intensity_str	structure of the intensity profile, options from ('SST_array','S_ST_mat','T_SS_mat', 'SS_T_mat'). See 'Details'.
frame	frame index
SZ	frame size of simulated image with default c(200, 200).
title	main title of the plot. If NA, title is "intensity profile for frame n" with n being the frame index in frame.
color	a logical evaluating to TRUE or FALSE indicating whether a colorful plot is generated

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#### **Details**

By default intensity\_str is set to 'T\_SS\_mat', a time by space×space matrix, which is the structure of intensity profile obtained from simulation class. For intensity\_str='SST\_array', input intensity profile should be a space by space by time array, which is the structure from loading a tif file. For intensity\_str='S\_ST\_mat', input intensity profile should be a space by space×time matrix. For intensity\_str='SS\_T\_mat', input intensity profile should be a space×space by time matrix.

#### Value

2D plot in gray scale (or with color) of selected frame.

### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

# **Examples**

```
library(AIUQ)
sim_bm = simulation(sz=100,len_t=100,sigma_bm=0.5)
show(sim_bm)
plot_intensity(sim_bm@intensity, sz=sim_bm@sz)
```

plot\_MSD

Plot estimated MSD with uncertainty from SAM class

#### **Description**

Function to plot estimated MSD with uncertainty from SAM class, versus true mean squared displacement(MSD) or given reference values.

### Usage

```
plot_MSD(object, msd_truth = NA, title = NA, log10 = TRUE)
```

# **Arguments**

object an S4 object of class SAM

msd\_truth a vector/matrix of true MSD or reference MSD value, default is NA

title main title of the plot. If NA, title is "model\_name" with model\_name being a field

in SAM class representing fitted model.

log10 a logical evaluating to TRUE or FALSE indicating whether a plot in log10 scale

is generated

# Value

A plot of estimated MSD with uncertainty versus truth/reference values.

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#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

# **Examples**

```
library(AIUQ)

## Simulate BM and get estimated parameters with uncertainty using BM model
# Simulation
set.seed(1)
sim_bm = simulation(sz=100,len_t=100,sigma_bm=0.5)
show(sim_bm)

# AIUQ method: fitting using BM model
sam = SAM(sim_object=sim_bm, uncertainty=TRUE,AIUQ_thr=c(0.999,0))
show(sam)

plot_MSD(object=sam, msd_truth=sam@msd_truth) #in log10 scale
plot_MSD(object=sam, msd_truth=sam@msd_truth,log10=FALSE) #in real scale
```

plot\_traj

Plot 2D particle trajectory

# **Description**

Function to plot the particle trajectory after the simulation class has been constructed.

# Usage

```
plot_traj(object, title = NA)
```

#### **Arguments**

object an S4 object of class simulation

title main title of the plot. If NA, title is "model\_name with M particles" with model\_name

and M being field in simulation class.

# Value

2D plot of particle trajectory for a given simulation from simulation class.

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### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

# **Examples**

```
library(AIUQ)
sim_bm = simulation(sz=100,len_t=100,sigma_bm=0.5)
show(sim_bm)
plot_traj(sim_bm)
```

SAM

Scattering analysis of microscopy

# **Description**

Fast parameter estimation in scattering analysis of microscopy, using either AIUQ or DDM method.

# Usage

```
SAM(
  intensity = NA,
  intensity_str = "T_SS_mat",
 pxsz = 1,
  sz = c(NA, NA),
 mindt = 1,
 AIUQ_{thr} = c(1, 1),
 model_name = "BM",
  sigma_0_2_ini = NaN,
 param_initial = NA,
  num\_optim = 1,
 msd_fn = NA,
 msd_grad_fn = NA,
 num_param = NA,
 uncertainty = FALSE,
 M = 50,
  sim_object = NA,
 msd_truth = NA,
 method = "AIUQ",
  index_q_AIUQ = NA,
  index_q_DDM = NA,
 message_out = TRUE,
 A_neg = "abs",
  square = FALSE,
  output_dqt = FALSE,
  output_isf = FALSE,
 output_modeled_isf = FALSE,
  output_modeled_dqt = FALSE
)
```

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#### **Arguments**

intensity intensity profile. See 'Details'.

intensity\_str structure of the intensity profile, options from ('SST\_array', 'S\_ST\_mat', 'T\_SS\_mat').

See 'Details'.

pxsz size of one pixel in unit of micron, 1 for simulated data

sz frame size of the intensity profile in x and y directions, number of pixels con-

tained in each frame equals sz\_x by sz\_y.

mindt minimum lag time, 1 for simulated data

AIUQ\_thr threshold for wave number selection, numeric vector of two elements with val-

ues between 0 and 1. See 'Details'.

model\_name fitted model, options from ('BM','OU','FBM','OU+FBM', 'user\_defined'), with

Brownian motion as the default model. See 'Details'.

sigma\_0\_2\_ini initial value for background noise. If NA, use minimum value of absolute square

of intensity profile in reciprocal space.

param\_initial initial values for param estimation.

num\_optim number of optimization.

msd\_fn user defined mean squared displacement(MSD) structure, a function of parame-

ters and lag times. NA if model\_name is not 'user defined'.

msd\_grad\_fn gradient for user defined mean squared displacement structure. If NA, then

numerical gradient will be used for parameter estimation in 'user\_defined'

model.

num\_param number of parameters need to be estimated in the intermediate scattering func-

tion, need to be non-NA value for user\_defined' model.

uncertainty a logical evaluating to TRUE or FALSE indicating whether parameter uncer-

tainty should be computed.

M number of particles. See 'Details'.

sim\_object NA or an S4 object of class simulation.

msd\_truth true MSD or reference MSD value.

method methods for parameter estimation, options from ('AIUQ','DDM fixedAB','DDM estAB').

index\_q\_DDM index range for wave number when using AIUQ method. See 'Details'. index\_q\_DDM method. See 'Details'.

message\_out a logical evaluating to TRUE or FALSE indicating whether or not to output the

message.

A\_neg controls modification for negative A(q), options from ('abs', 'zero'), with setting

negative A(q) to its absolute value as the default.

square a logical evaluating to TRUE or FALSE indicating whether or not to crop the

original intensity profile into square image.

output\_dqt a logical evaluating to TRUE or FALSE indicating whether or not to compute

observed dynamic image structure function(Dqt).

output\_isf a logical evaluating to TRUE or FALSE indicating whether or not to compute

empirical intermediate scattering function(ISF).

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output\_modeled\_isf

a logical evaluating to TRUE or FALSE indicating whether or not to compute modeled intermediate scattering function(ISF).

output\_modeled\_dqt

a logical evaluating to TRUE or FALSE indicating whether or not to compute modeled dynamic image structure function(Dqt).

#### **Details**

For simulated data using simulation in AIUQ package, intensity will be automatically extracted from simulation class.

By default intensity\_str is set to 'T\_SS\_mat', a time by space×space matrix, which is the structure of intensity profile obtained from simulation class. For intensity\_str='SST\_array', input intensity profile should be a space by space by time array, which is the structure from loading a tif file. For intensity\_str='S\_ST\_mat', input intensity profile should be a space by space×time matrix.

By default AIUQ\_thr is set to c(1,1), uses information from all complete q rings. The first element affects maximum wave number selected, and second element controls minimum proportion of wave number selected. By setting 1 for the second element, if maximum wave number selected is less than the wave number length, then maximum wave number selected is coerced to use all wave number unless user defined another index range through index\_q\_AIUQ.

If model\_name equals 'user\_defined', or NA (will coerced to 'user\_defined'), then msd\_fn and num\_param need to be provided for parameter estimation.

Number of particles M is set to 50 or automatically extracted from simulation class for simulated data using simulation in AIUQ package.

By default, using all wave vectors from complete q ring, unless user defined index range through index\_q\_AIUQ or index\_q\_DDM.

# Value

Returns an S4 object of class SAM.

# Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

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### **Examples**

```
library(AIUQ)
# Example 1: Estimation for simulated data
sim_bm = simulation(len_t=100,sz=100,sigma_bm=0.5)
show(sim_bm)
sam = SAM(sim_object = sim_bm)
show(sam)
```

SAM-class

SAM class

### **Description**

S4 class for fast parameter estimation in scattering analysis of microscopy, using either AIUQ or DDM method.

#### **Slots**

pxsz numeric. Size of one pixel in unit of micron with default value 1.

mindt numeric. Minimum lag time with default value 1.

sz vector. Frame size of the intensity profile in x and y directions, number of pixels contained in each frame equals sz\_x by sz\_y.

len\_t integer. Number of time steps.

len\_q integer. Number of wave vector.

q vector. Wave vector in unit of um^-1.

d\_input vector. Sequence of lag times.

B\_est\_ini numeric. Estimation of B. This parameter is determined by the noise in the system. See 'References'.

A\_est\_ini vector. Estimation of A(q). Note this parameter is determined by the properties of the imaged material and imaging optics. See 'References'.

I\_o\_q\_2\_ori vector. Absolute square of Fourier transformed intensity profile, ensemble over time.

q\_ori\_ring\_loc\_unique\_index list. List of location index of non-duplicate values for each q
 ring.

model\_name character. Fitted model, options from ('BM','OU','FBM','OU+FBM', 'user\_defined').

param\_est vector. Estimated parameters contained in MSD.

sigma\_2\_0\_est numeric. Estimated variance of background noise.

msd\_est vector. Estimated MSD.

uncertainty logical. A logical evaluating to TRUE or FALSE indicating whether parameter uncertainty should be computed.

msd\_lower vector. Lower bound of 95% confidence interval of MSD.

msd\_upper vector. Upper bound of 95% confidence interval of MSD.

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msd\_truth vector. True MSD or reference MSD value.

sigma\_2\_0\_truth vector. True variance of background noise, non NA for simulated data using simulation.

param\_truth vector. True parameters used to construct MSD, non NA for simulated data using simulation.

index\_q vector. Selected index of wave vector.

Dqt matrix. Dynamic image structure function D(q,delta t).

ISF matrix. Empirical intermediate scattering function f(q,delta t).

I\_q matrix. Fourier transformed intensity profile with structure 'SS\_T\_mat'.

AIC numeric. Akaike information criterion score.

mle numeric. Maximum log likelihood value.

param\_uq\_range matrix. 95% confidence interval for estimated parameters.

modeled\_Dqt matrix. Modeled dynamic image structure function D(q,delta t).

modeled\_ISF matrix. Modeled intermediate scattering function f(q,delta t).

#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

show.aniso\_sam

Show scattering analysis of microscopy for anisotropic processes (aniso\_SAM) object

### **Description**

Function to print the aniso\_SAM class object after the aniso\_SAM model has been constructed.

#### **Usage**

```
show.aniso_sam(object)
```

# **Arguments**

object

an S4 object of class aniso\_SAM

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### Value

Show a list of important parameters in class aniso\_SAM.

### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

# **Examples**

```
library(AIUQ)

## Simulate BM and get estimated parameters using BM model

# Simulation
aniso_sim_bm = aniso_simulation(sz=100,len_t=100,sigma_bm=c(0.5,0.3))
show(aniso_sim_bm)

# AIUQ method: fitting using BM model
aniso_sam = aniso_SAM(sim_object=aniso_sim_bm, AIUQ_thr=c(0.99,0))
show(aniso_sam)
```

show.aniso\_simulation Show anisotropic simulation object

# **Description**

Function to print the aniso\_simulation class object after the aniso\_simulation model has been constructed.

# Usage

```
show.aniso_simulation(object)
```

# Arguments

object

an S4 object of class aniso\_simulation

# Value

Show a list of important parameters in class aniso\_simulation.

show.sam

#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

#### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

### **Examples**

```
library(AIUQ)
```

```
# Simulate simple diffusion for 100 images with 100 by 100 pixels aniso_sim_bm = aniso_simulation(sz=100,len_t=100,sigma_bm=c(0.5,0.1)) show(aniso_sim_bm)
```

show.sam

Show scattering analysis of microscopy (SAM) object

# **Description**

Function to print the SAM class object after the SAM model has been constructed.

# Usage

```
show.sam(object)
```

# **Arguments**

object

an S4 object of class SAM

#### Value

Show a list of important parameters in class SAM.

### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

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# **Examples**

```
library(AIUQ)

## Simulate BM and get estimated parameters using BM model
# Simulation
sim_bm = simulation(sz=100,len_t=100,sigma_bm=0.5)
show(sim_bm)

# AIUQ method: fitting using BM model
sam = SAM(sim_object=sim_bm)
show(sam)
```

show.simulation

Show simulation object

# Description

Function to print the simulation class object after the simulation model has been constructed.

# Usage

```
show.simulation(object)
```

### **Arguments**

object

an S4 object of class simulation

#### Value

Show a list of important parameters in class simulation.

# Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

### References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

# **Examples**

```
library(AIUQ)
# Simulate simple diffusion for 100 images with 100 by 100 pixels
sim_bm = simulation(sz=100,len_t=100,sigma_bm=0.5)
show(sim_bm)
```

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simulation

Simulate 2D particle movement

# Description

Simulate 2D particle movement from a user selected stochastic process, and output intensity profiles.

# Usage

```
simulation(
  sz = c(200, 200),
 len_t = 200,
 M = 50,
 model_name = "BM",
 noise = "gaussian",
 I0 = 20,
 Imax = 255,
 pos0 = matrix(NaN, nrow = M, ncol = 2),
 rho = 0.95,
 H = 0.3,
  sigma_p = 2,
  sigma_bm = 1,
 sigma_ou = 2,
  sigma_fbm = 2
)
```

# **Arguments**

sz	frame size of simulated image with default c(200, 200).
len_t	number of time steps with default 200.
М	number of particles with default 50.
model_name	stochastic process simulated, options from ('BM','OU','FBM','OU+FBM'), with default 'BM'.
noise	background noise, options from ('uniform', 'gaussian'), with default 'gaussian'.
10	background intensity, value between 0 and 255, with default 20.
Imax	maximum intensity at the center of the particle, value between 0 and 255, with default 255.
pos0	initial position for M particles, matrix with dimension M by 2.
rho	correlation between successive step and previous step in O-U process, value between 0 and 1, with default 0.95.
Н	Hurst parameter of fractional Brownian Motion, value between 0 and 1, with default 0.3.
sigma_p	radius of the spherical particle (3sigma_p), with default 2.

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sigma_bm	distance moved per time step in Brownian Motion, with default 1.
sigma_ou	distance moved per time step in Ornstein-Uhlenbeck process, with default 2.
sigma_fbm	distance moved per time step in fractional Brownian Motion, with default 2.

### Value

Returns an S4 object of class simulation.

### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

# References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

### **Examples**

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simulation-class

Simulation class

# Description

S4 class for 2D particle movement simulation.

#### **Details**

intensity should has structure 'T\_SS\_mat', matrix with dimension len\_t by sz×sz.

pos should be the position matrix with dimension M×len\_t. See bm\_particle\_intensity, ou\_particle\_intensity, fbm\_particle\_intensity.

#### **Slots**

```
sz vector. Frame size of the intensity profile, number of pixels contained in each frame equals sz[1] by sz[2].

len_t integer. Number of time steps.

noise character. Background noise, options from ('uniform','gaussian').

model_name character. Simulated stochastic process, options from ('BM','OU','FBM','OU+FBM').

M integer. Number of particles.

pxsz numeric. Size of one pixel in unit of micron, 1 for simulated data.

mindt numeric. Minimum lag time, 1 for simulated data.

pos matrix. Position matrix for particle trajectory, see 'Details'.

intensity matrix. Filled intensity profile, see 'Details'.

num_msd vector. Numerical mean squared displacement (MSD).

param vector. Parameters for simulated stochastic process.

theor_msd vector. Theoretical MSD.

sigma_2_0 vector. Variance of background noise.
```

#### Author(s)

Yue He [aut], Xubo Liu [aut], Mengyang Gu [aut, cre]

# References

Gu, M., He, Y., Liu, X., & Luo, Y. (2023). Ab initio uncertainty quantification in scattering analysis of microscopy. arXiv preprint arXiv:2309.02468.

Gu, M., Luo, Y., He, Y., Helgeson, M. E., & Valentine, M. T. (2021). Uncertainty quantification and estimation in differential dynamic microscopy. Physical Review E, 104(3), 034610.

Cerbino, R., & Trappe, V. (2008). Differential dynamic microscopy: probing wave vector dependent dynamics with a microscope. Physical review letters, 100(18), 188102.

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